

FDMT800120DC N-Channel Dual CoolTM 88 PowerTrench[®] MOSFET 120 V, 128 A, 4.2 m Ω

Features

- Max $r_{DS(on)}$ = 4.2 m Ω at V_{GS} = 10 V, I_D = 20 A
- Max $r_{DS(on)} = 6.4 \text{ m}\Omega \text{ at } V_{GS} = 6 \text{ V}, I_D = 16 \text{ A}$
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery
- Low profile 8x8mm MLP package
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

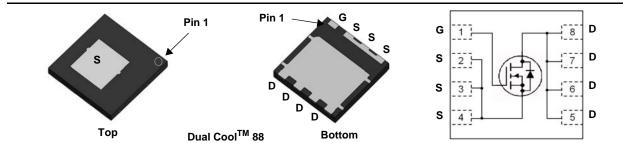


General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench[®] process. Advancements in both silicon and Dual CoolTM package technologies have been combined to offer the lowest $r_{DS(on)}$ while maintaining excellent switching performance by extremely low Junction-to-Ambient thermal resistance.

Applications

- OringFET / Load Switching
- Synchronous Rectification
- DC-DC Conversion



MOSFET Maximum Ratings $T_A = 25$ °C unless otherwise noted.

Symbol	Paramete	er		Ratings	Units	
V _{DS}	Drain to Source Voltage			120	V	
V _{GS}	Gate to Source Voltage			±20	V	
	Drain Current -Continuous	T _C = 25 °C	(Note 5)	128		
	-Continuous	T _C = 100 °C	(Note 5)	81		
ID	-Continuous	T _A = 25 °C	(Note 1a)	20	Α	
	-Pulsed		(Note 4)	767		
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	1350	mJ	
D	Power Dissipation	T _C = 25 °C		156	W	
PD	Power Dissipation	T _A = 25 °C	(Note 1a)	3.2	VV	
T _J , T _{STG}	Operating and Storage Junction Temperatu	ire Range		-55 to +150	°C	

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Top Source)	1.6	
R _{θJC}	Thermal Resistance, Junction-to-Case	(Bottom Drain)	0.8	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	38	
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1b)	81	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1i)	15	
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1j)	21	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1k)	9	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
800120DC	FDMT800120DC	Dual Cool TM 88	13"	13.3 mm	3000 units

July 2015

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units	
Off Chara	cteristics						
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0 \ V$	120			V	
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, referenced to 25 °C		97		mV/°C	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 96 V, V _{GS} = 0 V			1	μA	
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			100	nA	
On Chara	cteristics						
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \ \mu A$	2.0	3.1	4.0	V	
$\Delta V_{GS(th)}$ $\Delta T_{.1}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$, referenced to 25 °C		-12		mV/°C	
5		V _{GS} = 10 V, I _D = 20 A		3.45	4.2		
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 6 V, I _D = 16 A		4.6	6.4	mΩ	
()		V _{GS} = 10 V, I _D = 20 A, T _J = 125 °C		6.3	7.7	1	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 20 A		69		S	
C _{iss}	Characteristics Input Capacitance			5605	7850	pF	
C _{iss} C _{oss}	Output Capacitance	$-V_{DS} = 60 V, V_{GS} = 0 V,$		778	1090	ρΓ PG	
C _{rss}	Reverse Transfer Capacitance	f = 1 MHz		27	40	pF	
R _g	Gate Resistance		0.1	1.4	3.5	Ω	
×	g Characteristics						
t _{d(on)}	Turn-On Delay Time			29	47	ns	
t _r	Rise Time	V _{DD} = 60 V, I _D = 20 A,		18	33	ns	
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, \text{ R}_{GEN} = 6 \Omega$		40	64	ns	
t _f	Fall Time			9.5	19	ns	
Q _{q(TOT)}	Total Gate Charge	V _{GS} = 0 V to 10 V		76	107	nC	
Q _{g(TOT)}	Total Gate Charge	$V_{GS} = 0 V \text{ to } 6 V$ $V_{DD} = 60 V,$		48	68	nC	
Q _{gs}	Gate to Source Charge	$I_D = 20 \text{ A}$		25		nC	
Q _{gd}	Gate to Drain "Miller" Charge	_		15		nC	
Drain-Sou	urce Diode Characteristics						
		$V_{GS} = 0 V, I_S = 2.9 A$ (Note 2)		0.7	1.1	1	
V _{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 20 A$ (Note 2)		0.8	1.2	V	
	1			-			
t _{rr}	Reverse Recovery Time	I _F = 20 A, di/dt = 100 A/μs		87	139	ns	

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$R_{ ext{ heta}JC}$	Thermal Resistance, Junction-to-Case	(Top Source)	1.6	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Bottom Drain)	0.8	
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	38	
R _{0JA}	Thermal Resistance, Junction-to-Ambient	(Note 1b)	81	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1c)	26	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1d)	34	
R _{0JA}	Thermal Resistance, Junction-to-Ambient	(Note 1e)	14	0044
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1f)	16	°C/M
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1g)	26	
R _{0JA}	Thermal Resistance, Junction-to-Ambient	(Note 1h)	60	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1i)	15	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1j)	21	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1k)	9	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1I)	11	

NOTES:

1. R_{0JA} is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R_{0CA} is determined by the user's board design.



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c. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in² pad of 2 oz copper

d. Still air, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

- e. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper
- f. Still air, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

a. 38 °C/W when mounted on

a 1 in² pad of 2 oz copper

g. 200FPM Airflow, No Heat Sink,1 in² pad of 2 oz copper

h. 200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper

i. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, 1 in 2 pad of 2 oz copper

j. 200FPM Airflow, 20.9x10.4x12.7mm Aluminum Heat Sink, minimum pad of 2 oz copper

k. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in² pad of 2 oz copper

I. 200FPM Airflow, 45.2x41.4x11.7mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper

2. Pulse Test: Pulse Width < 300 $\mu s,$ Duty cycle < 2.0%.

3. E_{AS} of 1350 mJ is based on starting T_J = 25 °C; N-ch: L = 3 mH, I_{AS} = 30 A, V_{DD} = 120 V, V_{GS} =10 V. 100% test at L = 0.1 mH, I_{AS} = 93 A.

4. Pulsed Id please refer to Fig 11 SOA graph for more details.

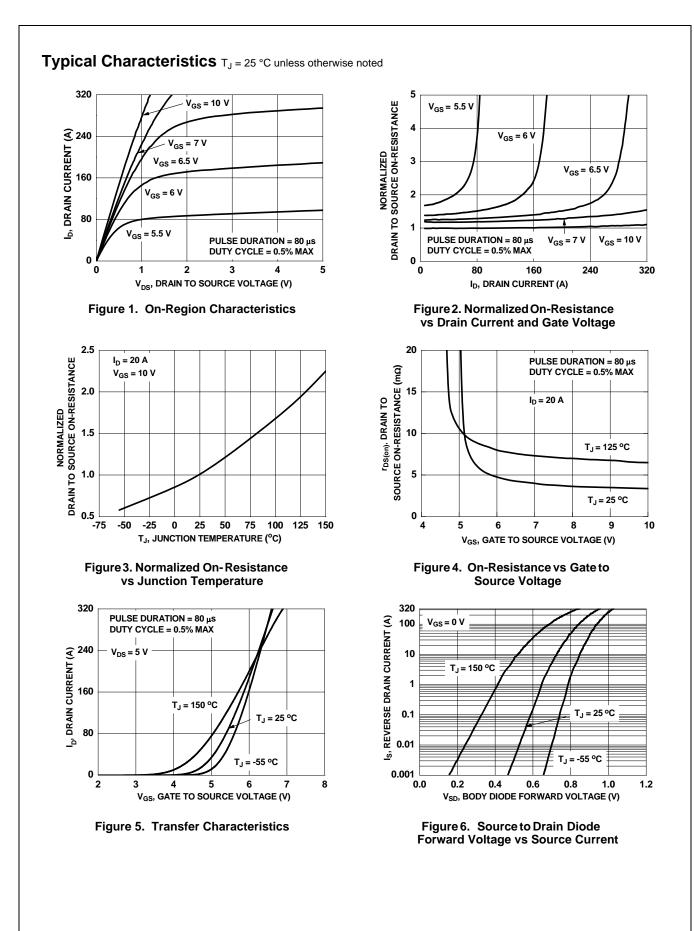
5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro-mechanical application board design.

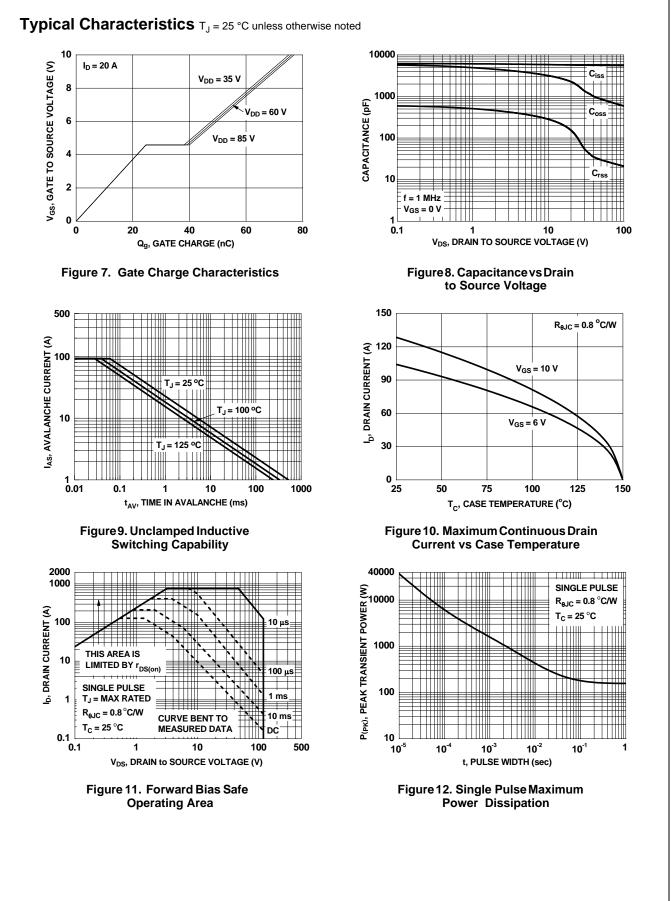
b. 81 °C/W when mounted on

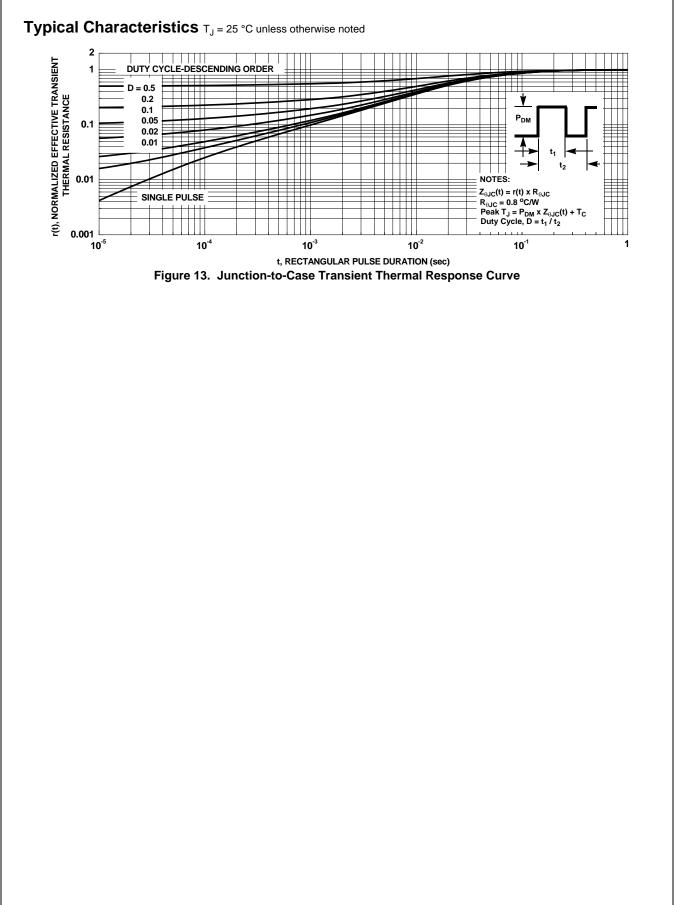
GSSPD

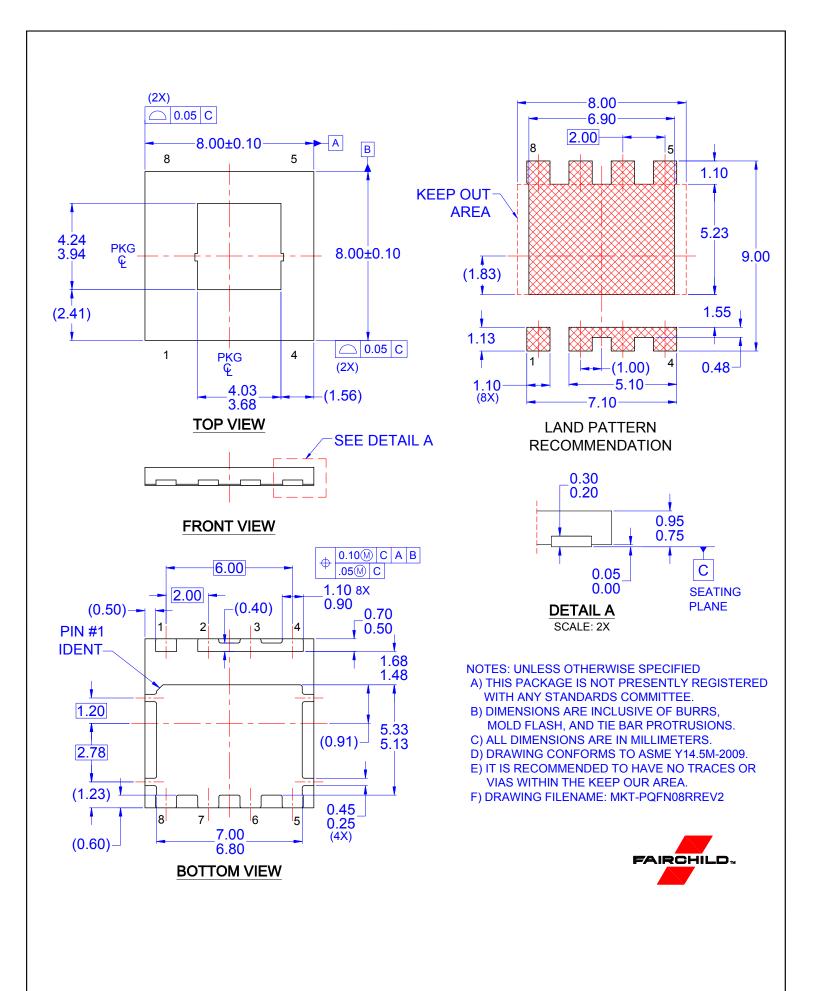
a minimum pad of 2 oz copper











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